

# VR11.1, VR12 Compatible Synchronous Rectified Buck MOSFET Driver

## ISL6627

The ISL6627 is a high frequency MOSFET driver designed to drive upper and lower power N-Channel MOSFETs in a synchronous rectified buck converter topology. The advanced PWM protocol of ISL6627 is specifically designed to work with Intersil VR11.1, VR12 controllers and combined with N-Channel MOSFETs to form a complete core-voltage regulator solution for advanced microprocessors. When ISL6627 detects a  $\overline{\text{PSI}}$  protocol sent by an Intersil VR11.1, VR12 controller, it activates Diode Emulation (DE) operation; otherwise, it operates in normal Continuous Conduction Mode (CCM) PWM mode.

To further enhance light load efficiency, the ISL6627 enables diode emulation operation during  $\overline{\text{PSI}}$  mode. This allows Discontinuous Conduction Mode (DCM) by detecting when the inductor current reaches zero and subsequently turning off the low side MOSFET to prevent it from sinking current.

When ISL6627 detects Diode Braking command from the PWM, it turns off both gates and reduces overshoot in load transient situations.

An advanced adaptive shoot-through protection is integrated to prevent both the upper and lower MOSFETs from conducting simultaneously and to minimize dead time. The user also has the option to program the driver working in fixed propagation delay mode to optimize the regulator efficiency. The ISL6627 has a 20k $\Omega$  integrated high-side gate-to-source resistor to prevent self turn-on due to high input bus dV/dt.

## Related Literature

- Technical Brief [TB363](#) "Guidelines for Handling and Processing Moisture Sensitive Surface Mount Devices (SMDs)"
- Technical Brief [TB417](#) "Designing Stable Compensation Networks for Single Phase Voltage Mode Buck Regulators"

## Features

- Intersil VR11.1 and VR12 Compatible
- Dual MOSFET Driver for Synchronous Rectified Bridge
- Advanced Adaptive Zero Shoot-through Protection
- Programmable Fixed Deadtime for Efficiency Optimization
- Low Standby Bias Current
- 36V Internal Bootstrap Diode
- Bootstrap Capacitor Overcharge Prevention
- Supports High Switching Frequency
  - 4A Sinking Current Capability
  - Fast Rise/Fall Times and Low Propagation Delays
- Integrated High-Side Gate-to-Source Resistor to Prevent Self Turn-on Due to High Input Bus dV/dt
- Power Rails Undervoltage Protection
- Expandable Bottom Copper Pad for Enhanced Heat Sinking
- Dual Flat 10 Ld (3x3 DFN) Package
  - Near Chip-Scale Package Footprint; Improves PCB Efficiency and Thinner in Profile
- Pb-Free (RoHS Compliant)

## Applications

- High Light Load Efficiency Voltage Regulators
- Core Regulators for Advanced Microprocessors
- High Current DC/DC Converters
- High Frequency and High Efficiency VRM and VRD

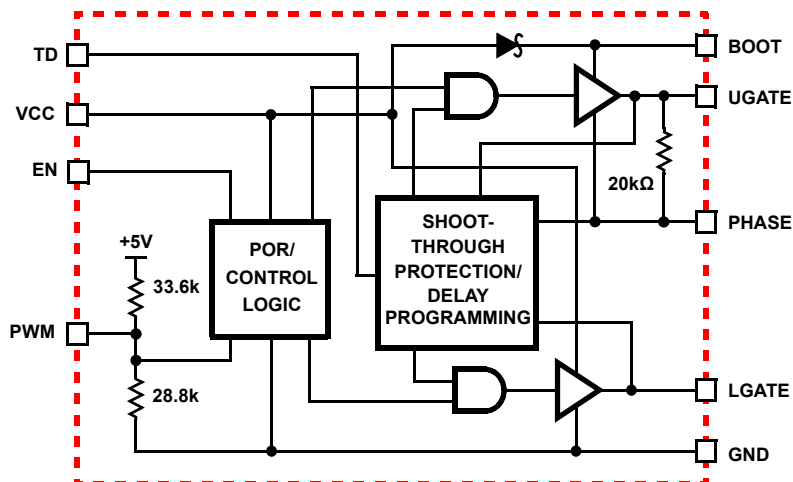
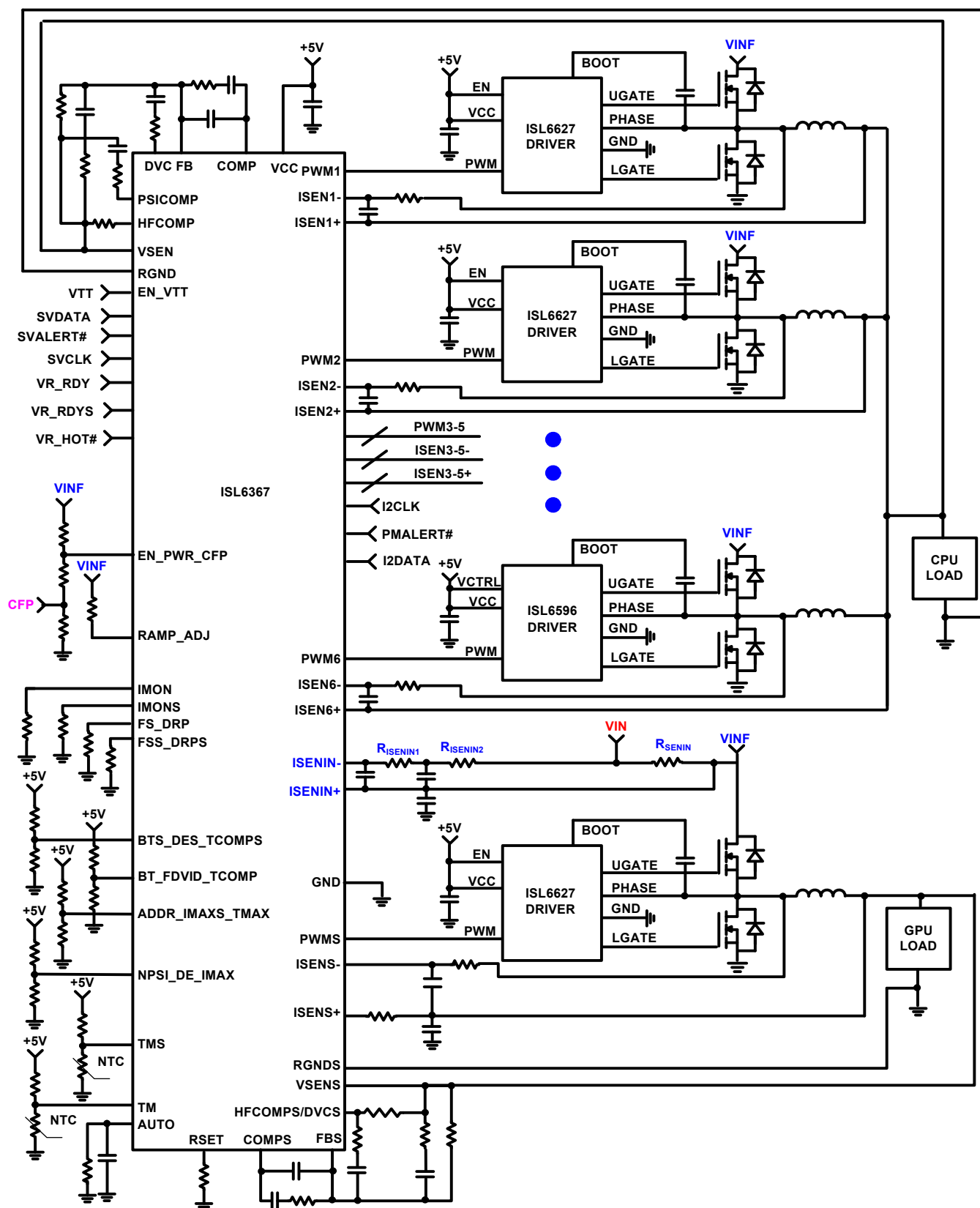


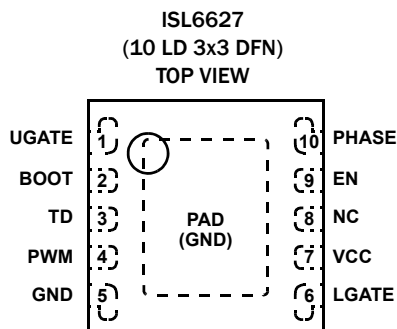
FIGURE 1. ISL6627 BLOCK DIAGRAM

## Typical Application Circuit



NTC: BETA = 3477

## Pin Configuration



## Functional Pin Descriptions

| PIN # | SYMBOL | DESCRIPTION                                                                                                                                                                                                                                                                                  |
|-------|--------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1     | UGATE  | Upper gate drive output. Connect to gate of high-side power N-Channel MOSFET.                                                                                                                                                                                                                |
| 2     | BOOT   | Floating bootstrap supply pin for the upper gate drive. Connect the bootstrap capacitor between this pin and the PHASE pin. The bootstrap capacitor provides the charge to turn on the upper MOSFET. See "Internal Bootstrap Device" on page 7 for guidance in choosing the capacitor value. |
| 3     | TD     | Deadtime programming pin. Connect to ground or VCC via resistor to program fixed time delay from LGATE fall to UGATE rise or UGATE fall to LGATE rise. Open pin sets the adaptive mode. See Table 1 for more details.                                                                        |
| 4     | PWM    | Control input for the driver. The PWM signal can enter three distinct states during operation; see "Advanced PWM Protocol (Patent Pending)" on page 6 for further details. Connect this pin to the PWM output of the controller.                                                             |
| 5     | GND    | Bias and reference ground. All signals are referenced to this node. It is also the power ground return of the driver.                                                                                                                                                                        |
| 6     | LGATE  | Lower gate drive output. Connect to gate of the low-side power N-Channel MOSFET.                                                                                                                                                                                                             |
| 7     | VCC    | Connect to 5V bias supply. This pin supplies power to the gate drives and small-signal circuitry. Place a high quality low ESR ceramic capacitor from this pin to GND.                                                                                                                       |
| 8     | NC     | No connection.                                                                                                                                                                                                                                                                               |
| 9     | EN     | Enable input pin. Connect this pin high to enable the driver and low to disable the driver.                                                                                                                                                                                                  |
| 10    | PHASE  | Connect this pin to the SOURCE of the upper MOSFET and the DRAIN of the lower MOSFET. This pin provides a return path for the upper gate drive.                                                                                                                                              |
| -     | PAD    | EPAD at ground potential. Soldering it directly to GND plane is required for thermal considerations.                                                                                                                                                                                         |

## Ordering Information

| PART NUMBER<br>(Notes 1, 2, 3) | PART<br>MARKING | TEMP. RANGE<br>(°C) | PACKAGE<br>(Pb-Free) | PKG.<br>DWG. # |
|--------------------------------|-----------------|---------------------|----------------------|----------------|
| ISL6627CRZ                     | 6627            | 0 to +70            | 10 Ld 3x3 DFN        | L10.3X3        |
| ISL6627IRZ                     | 627I            | -40 to +85          | 10 Ld 3x3 DFN        | L10.3X3        |

### NOTES:

1. Add "-T\*" suffix for tape and reel. Please refer to [TB347](#) for details on reel specifications.
2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
3. For Moisture Sensitivity Level (MSL), please see device information page for [ISL6627](#). For more information on MSL please see techbrief [TB363](#).

## Absolute Maximum Ratings

|                                                     |                                                                        |
|-----------------------------------------------------|------------------------------------------------------------------------|
| Supply Voltage (VCC)                                | -0.3V to 7V                                                            |
| Input Voltage (V <sub>EN</sub> , V <sub>PWM</sub> ) | -0.3V to VCC + 0.3V                                                    |
| BOOT Voltage (V <sub>BOOT-GND</sub> )               | -0.3V to 25V (DC) or 36V (<200ns)                                      |
| BOOT to PHASE Voltage (V <sub>BOOT-PHASE</sub> )    | -0.3V to 7V (DC)                                                       |
|                                                     | -0.3V to 9V (<10ns)                                                    |
| PHASE Voltage                                       | GND - 0.3V to 25V (DC)                                                 |
|                                                     | GND - 8V (<20ns Pulse Width, 10μJ) to 30V (<100ns)                     |
| UGATE Voltage                                       | V <sub>PHASE</sub> - 0.3V (DC) to V <sub>BOOT</sub>                    |
|                                                     | V <sub>PHASE</sub> - 5V (<20ns Pulse Width, 10μJ) to V <sub>BOOT</sub> |
| LGATE Voltage                                       | GND - 0.3V (DC) to VCC + 0.3V                                          |
|                                                     | GND - 2.5V (<20ns Pulse Width, 5μJ) to VCC + 0.3V                      |
| Ambient Temperature Range                           | -40°C to +125°C                                                        |
| ESD Rating                                          |                                                                        |
| Human Body Model                                    | 2.5kV                                                                  |
| Charged Device Model                                | 1kV                                                                    |
| Latch Up (Tested per JESD78C; Class II, Level A)    | 100mA                                                                  |

## Thermal Information

|                                                |                                                                                                                 |                      |
|------------------------------------------------|-----------------------------------------------------------------------------------------------------------------|----------------------|
| Thermal Resistance                             | $\theta_{JA}$ (°C/W)                                                                                            | $\theta_{JC}$ (°C/W) |
| 10 Ld 3x3 DFN Package (Notes 4, 5)             | 51                                                                                                              | 10                   |
| Maximum Junction Temperature (Plastic Package) | +150°C                                                                                                          |                      |
| Maximum Storage Temperature Range              | -65°C to +150°C                                                                                                 |                      |
| Pb-Free Reflow Profile                         | see link below                                                                                                  |                      |
|                                                | <a href="http://www.intersil.com/pbfree/Pb-FreeReflow.asp">http://www.intersil.com/pbfree/Pb-FreeReflow.asp</a> |                      |

## Recommended Operating Conditions

|                                        |                |
|----------------------------------------|----------------|
| Ambient Temperature Range (ISL6627IRZ) | -40°C to +85°C |
| Ambient Temperature Range (ISL6627CRZ) | 0°C to +70°C   |
| Maximum Operating Junction Temperature | +125°C         |
| Supply Voltage, VCC                    | 5V ±10%        |

**CAUTION:** Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

### NOTES:

- $\theta_{JA}$  is measured in free air with the component mounted on a high effective thermal conductivity test board with “direct attach” features. See Tech Brief [TB379](#).
- For  $\theta_{JC}$ , the “case temp” location is the center of the exposed metal pad on the package underside.

## Electrical Specifications

Recommended Operating Conditions, Unless Otherwise Noted. **Boldface limits apply over the operating temperature range.**

| PARAMETER                                  | SYMBOL | TEST CONDITIONS                                | MIN<br>(Note 7) | TYP  | MAX<br>(Note 7) | UNITS |
|--------------------------------------------|--------|------------------------------------------------|-----------------|------|-----------------|-------|
| VCC SUPPLY CURRENT                         |        |                                                |                 |      |                 |       |
| No Load Switching Supply Current           | IVCC   | f_PWM = 300kHz, VCC = 5V, EN = High            |                 | 1.27 |                 | mA    |
| Standby Supply Current                     | IVCC   | VCC = 5V, PWM 0V to 2.5V transition, EN = High |                 | 1.85 |                 | mA    |
|                                            |        | VCC = 5V, PWM 0V to 2.5V transition, EN = Low  |                 | 1.15 |                 | mA    |
| POWER-ON RESET AND ENABLE                  |        |                                                |                 |      |                 |       |
| VCC Rising POR Threshold                   |        |                                                | 3.20            | 3.85 | 4.40            | V     |
| VCC Falling POR Threshold                  |        |                                                | 3.00            | 3.52 | 4.00            | V     |
| VCC POR Hysteresis                         |        |                                                | 130             | 300  | 530             | mV    |
| EN High Threshold                          |        |                                                | 1.40            | 1.65 | 1.90            | V     |
| EN Low Threshold                           |        |                                                | 1.20            | 1.35 | 1.55            | V     |
| PWM INPUT (See “TIMING DIAGRAM” on page 6) |        |                                                |                 |      |                 |       |
| Input Current                              | IPWM   | VPWM = 5V                                      |                 | 155  |                 | μA    |
|                                            |        | VPWM = 0V                                      |                 | -133 |                 | μA    |
| Three-State Lower Gate Falling Threshold   |        | VCC = 5V                                       |                 | 1.6  |                 | V     |
| Three-State Lower Gate Rising Threshold    |        | VCC = 5V                                       |                 | 1.1  |                 | V     |
| Three-State Upper Gate Rising Threshold    |        | VCC = 5V                                       |                 | 3.2  |                 | V     |
| Three-state Upper Gate Falling Threshold   |        | VCC = 5V                                       |                 | 2.8  |                 | V     |
| UGATE Rise Time (Note 6)                   | t_RU   | VCC = 5V, 3nF load, 10% to 90%                 |                 | 8    |                 | ns    |
| LGATE Rise Time (Note 6)                   | t_RL   | VCC = 5V, 3nF load, 10% to 90%                 |                 | 8    |                 | ns    |
| UGATE Fall Time (Note 6)                   | t_FU   | VCC = 5V, 3nF load, 10% to 90%                 |                 | 8    |                 | ns    |
| LGATE Fall Time (Note 6)                   | t_FL   | VCC = 5V, 3nF load, 10% to 90%                 |                 | 4    |                 | ns    |
| UGATE Turn-On Propagation Delay (Note 6)   | t_PDHU | VCC = 5V, 3nF load, adaptive                   |                 | 28   |                 | ns    |
| LGATE Turn-On Propagation Delay (Note 6)   | t_PDHL | VCC = 5V, 3nF load, adaptive                   |                 | 16   |                 | ns    |
| UGATE Turn-Off Propagation Delay (Note 6)  | t_PDLU | VCC = 5V, 3nF load                             |                 | 15   |                 | ns    |

# ISL6627

## Electrical Specifications Recommended Operating Conditions, Unless Otherwise Noted. **Boldface limits apply over the operating temperature range. (Continued)**

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS                                               | MIN<br>(Note 7) | TYP | MAX<br>(Note 7) | UNITS |
|-------------------------------------------|-----------------------|---------------------------------------------------------------|-----------------|-----|-----------------|-------|
| LGATE Turn-Off Propagation Delay (Note 6) | t <sub>PDLL</sub>     | VCC = 5V, 3nF load                                            |                 | 14  |                 | ns    |
| Minimum LGATE on Time at Diode Emulation  | t <sub>LG_ON_DM</sub> | VCC = 5V                                                      | 230             | 330 | 450             | ns    |
| PROPAGATION DELAY PROGRAMMING             |                       |                                                               |                 |     |                 |       |
| UGATE Fall to LGATE Rise Time             | t <sub>PDUFLR</sub>   | VCC = 5V, 3nF Load, 90% to 10%, short resistor from TD to VCC |                 | 23  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, 100kΩ resistor from TD to VCC |                 | 18  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, 330kΩ resistor from TD to VCC |                 | 15  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, 910kΩ resistor from TD to VCC |                 | 7   |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, short resistor from TD to GND |                 | 18  |                 | ns    |
| LGATE Fall to UGATE Rise Time             | t <sub>PDLFUR</sub>   | VCC = 5V, 3nF Load, 90% to 10%, short resistor from TD to GND |                 | 40  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, 100kΩ resistor from TD to GND |                 | 25  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, 360kΩ resistor from TD to GND |                 | 17  |                 | ns    |
|                                           |                       | VCC = 5V, 3nF Load, 90% to 10%, short resistor from TD to VCC |                 | 27  |                 | ns    |
| OUTPUT (Note 6)                           |                       |                                                               |                 |     |                 |       |
| Upper Drive Source Current                | I <sub>U_SOURCE</sub> | VCC = 5V, 3nF load                                            |                 | 2   |                 | A     |
| Upper Drive Source Impedance              | R <sub>U_SOURCE</sub> | 20mA source current                                           |                 | 1   |                 | Ω     |
| Upper Drive Sink Current                  | I <sub>U_SINK</sub>   | VCC = 5V, 3nF load                                            |                 | 2   |                 | A     |
| Upper Drive Sink Impedance                | R <sub>U_SINK</sub>   | 20mA sink current                                             |                 | 1   |                 | Ω     |
| Lower Drive Source Current                | I <sub>L_SOURCE</sub> | VCC = 5V, 3nF load                                            |                 | 2   |                 | A     |
| Lower Drive Source Impedance              | R <sub>L_SOURCE</sub> | 20mA source current                                           |                 | 1   |                 | Ω     |
| Lower Drive Sink Current                  | I <sub>L_SINK</sub>   | VCC = 5V, 3nF load                                            |                 | 4   |                 | A     |
| Lower Drive Sink Impedance                | R <sub>L_SINK</sub>   | 20mA sink current                                             |                 | 0.4 |                 | Ω     |

### NOTES:

- Limits established by characterization and are not production tested.
- Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

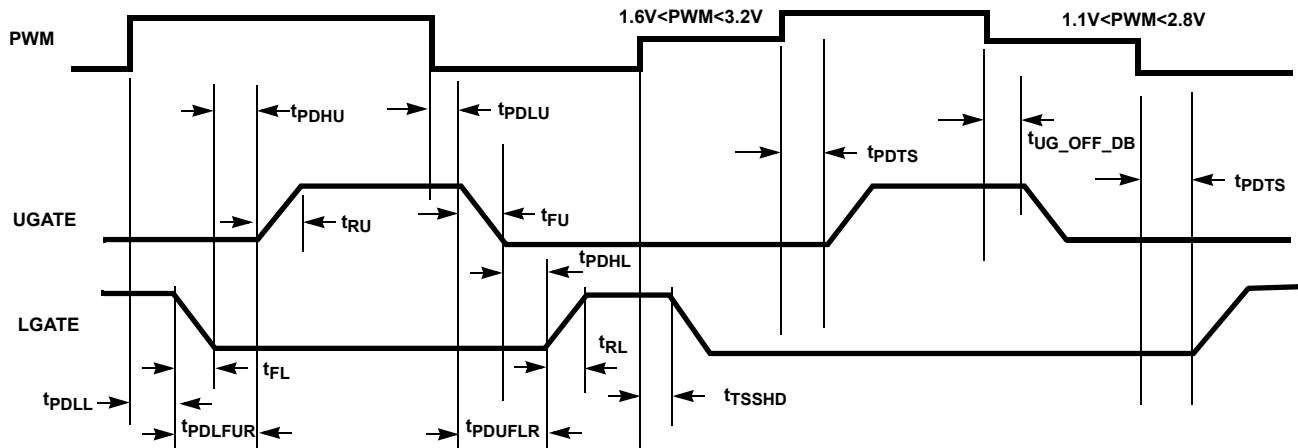


FIGURE 2. TIMING DIAGRAM

## Operation and Adaptive Shoot-Through Protection

Designed for high speed switching, the ISL6627 MOSFET driver controls both high-side and low-side N-Channel FETs from one externally-provided PWM signal.

A rising transition on PWM initiates the turn-off of the lower MOSFET (see “Timing Diagram”). After a short propagation delay [ $t_{PDLL}$ ], the lower gate begins to fall. Typical fall times [ $t_{FL}$ ] are provided in the “Electrical Specifications” on page 4. Adaptive shoot-through circuitry monitors the LGATE voltage and turns on the upper gate following a short delay time [ $t_{PDHU}$ ] after the LGATE voltage drops below  $\sim 1V$ . The user also has the option to program the propagation delay as described in “Deadtime Programming” on page 6. The upper gate drive then begins to rise [ $t_{RU}$ ] and the upper MOSFET turns on.

A falling transition on PWM indicates the turn-off of the upper MOSFET and the turn-on of the lower MOSFET. A short propagation delay [ $t_{PDLU}$ ] is encountered before the upper gate begins to fall [ $t_{FU}$ ]. The adaptive shoot-through circuitry monitors the UGATE-PHASE voltage and turns on the lower MOSFET a short delay time [ $t_{PDHL}$ ], after the upper MOSFET’s gate voltage drops below  $1V$ . The lower gate then rises [ $t_{RL}$ ], turning on the lower MOSFET. These methods prevent both the lower and upper MOSFETs from conducting simultaneously (shoot-through), while adapting the dead time to the gate charge characteristics of the MOSFETs being used. The user also has the option to program the propagation delay as described in “Deadtime Programming” on page 6.

This driver is optimized for voltage regulators with a large step down ratio. The lower MOSFET is usually sized larger compared to the upper MOSFET because the lower MOSFET conducts for a longer time during a switching period. The lower gate driver is therefore sized much larger to meet this application requirement. The  $0.4\Omega$  ON-resistance and 4A sink current capability enable the lower gate driver to absorb the charge injected into the lower gate through the drain-to-gate capacitor of the lower MOSFET and help prevent shoot through caused by the self turn-on of the lower MOSFET due to high  $dV/dt$  of the switching node.

## Advanced PWM Protocol (Patent Pending)

The advanced PWM protocol of ISL6627 is specifically designed to work with Intersil VR11.1 and VR12 controllers. When ISL6627 detects a PSI# protocol sent by an Intersil VR11.1/VR12 controller, it turns on diode emulation operation; otherwise, it remains in normal CCM PWM mode.

Note that for a PWM low to tri-level (2.5V) transition, the LGATE will not turn off until the its diode emulation minimum ON-time of 330ns (typically) passes.

## Diode Emulation

Diode emulation allows for higher converter efficiency under light-load situations. With diode emulation active, the ISL6627 detects the zero current crossing of the output inductor and turns off LGATE, preventing the low side MOSFET from sinking current and ensuring discontinuous conduction mode (DCM) is achieved. In DCM mode, LGATE has a minimum ON-time of 330ns (typically).

## Deadtime Programming

The part provides the user with the option to program either of the two gate propagation delays (as defined in Figure 3) in order to optimize the deadtime and maximize the efficiency of the circuit. Tying the TD pin to either GND or VCC through a specified-value resistor leads the driver to operate in fixed gate propagation delay mode. Leaving the TD pin floating results in the driver operating in adaptive deadtime mode. Refer to Table 1 for typical programming resistor value options. Propagation delay has a typical tolerance of 30%. As actual deadtime depends on FET switching transition characteristics, while operating in fixed propagation delay mode, the user needs to monitor the gate transitions under worst-case operating conditions and use appropriate design margin to prevent eventual shoot-through due to insufficient dead time.

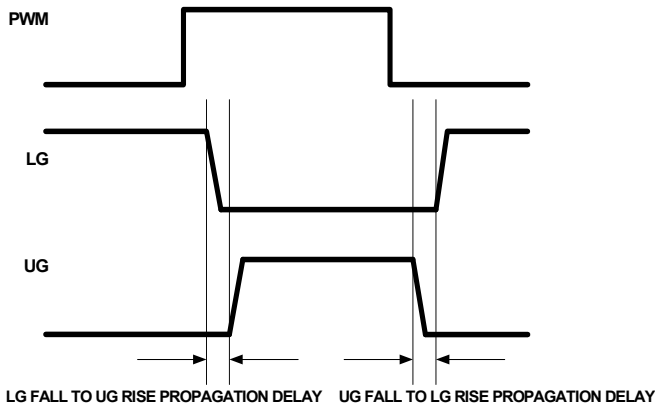


FIGURE 3. PROGRAMMABLE PROPAGATION DELAY ILLUSTRATION

TABLE 1. TYPICAL DELAY PROGRAMMING RESISTOR VALUE

| RESISTOR FROM TD TO VCC (kΩ) | RESISTOR FROM TD TO GND (kΩ) | LG FALL TO UG RISE DELAY (ns) | UG FALL TO LG RISE DELAY (ns) |
|------------------------------|------------------------------|-------------------------------|-------------------------------|
| short                        | -                            | 27                            | 23                            |
| 100                          | -                            | 27                            | 18                            |
| 330                          | -                            | 27                            | 15                            |
| 910                          | -                            | 27                            | 7                             |
| -                            | Short                        | 40                            | 18                            |
| -                            | 100                          | 25                            | 18                            |
| -                            | 360                          | 17                            | 18                            |
| Floating                     | Floating                     | Adaptive                      | Adaptive                      |

## Power-On Reset (POR) Function

VCC voltage level is monitored at all times. Once the VCC voltage exceeds 3.85V (typically), operation of the driver is enabled and the PWM input signal takes control of the gate drivers. If VCC drops below the falling threshold of 3.52V (typically), operation of the driver is disabled.

## Internal Bootstrap Device

ISL6627 features an internal bootstrap schottky diode. Simply adding an external capacitor across the BOOT and PHASE pins completes the bootstrap circuit. The bootstrap function is also designed to prevent the bootstrap capacitor from overcharging due to the large negative swing at the trailing-edge of the PHASE node excursion. This reduces the potential for overstressing the upper driver.

The bootstrap capacitor must have a voltage rating above the maximum VCC voltage. Its capacitance value can be estimated from Equation 1:

$$C_{BOOT\_CAP} \geq \frac{Q_{GATE}}{\Delta V_{BOOT\_CAP}} \quad (EQ. 1)$$

$$Q_{GATE} = \frac{Q_{G1} \cdot V_{CC}}{V_{GS1}} \cdot N_{Q1}$$

where  $Q_{G1}$  is the amount of gate charge per upper MOSFET at  $V_{GS1}$  gate-source voltage and  $N_{Q1}$  is the number of control (upper) MOSFETs. The  $\Delta V_{BOOT\_CAP}$  term is defined as the allowable droop in the rail of the upper gate drive. Select results are exemplified in Figure 4.

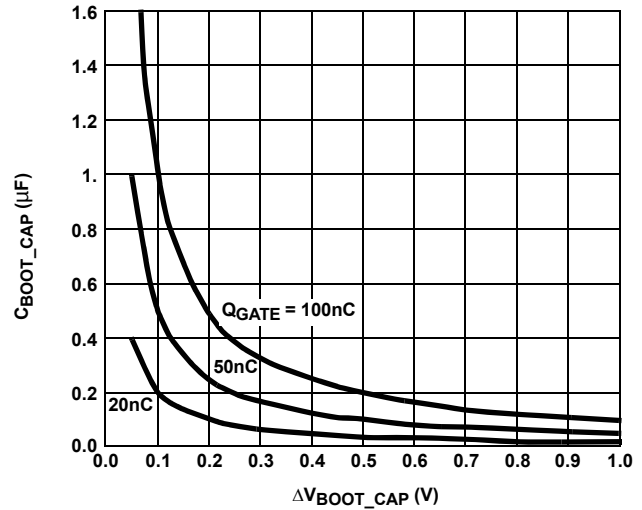


FIGURE 4. BOOTSTRAP CAPACITANCE vs BOOT RIPPLE VOLTAGE

## Power Dissipation

Package power dissipation is mainly a function of the switching frequency ( $F_{SW}$ ), the output drive impedance, the layout resistance, the selected MOSFET's internal gate resistance and its total gate charge ( $Q_G$ ). Calculating the power dissipation in the driver for a desired application is critical to ensure safe operation. Exceeding the maximum allowable power dissipation level may push the IC beyond the maximum recommended operating junction temperature. The DFN package is more suitable for high frequency applications. See "Layout Considerations" on page 8 for thermal impedance improvement suggestions. The total driver power loss, essentially MOSFETs' gate charge and driver internal circuitry losses, can be estimated using Equations 2 and 3, respectively.

$$P_{Qg\_TOT} = P_{Qg\_Q1} + P_{Qg\_Q2} + I_Q \cdot V_{CC}$$

$$P_{Qg\_Q1} = \frac{Q_{G1} \cdot UV_{CC}^2}{V_{GS1}} \cdot F_{SW} \cdot N_{Q1} \quad (EQ. 2)$$

$$P_{Qg\_Q2} = \frac{Q_{G2} \cdot LV_{CC}^2}{V_{GS2}} \cdot F_{SW} \cdot N_{Q2}$$

$$I_{DR} = \left( \frac{Q_{G1} \cdot UV_{CC} \cdot N_{Q1}}{V_{GS1}} + \frac{Q_{G2} \cdot LV_{CC} \cdot N_{Q2}}{V_{GS2}} \right) \cdot F_{SW} + I_Q \quad (EQ. 3)$$

where the gate charge ( $Q_{G1}$  and  $Q_{G2}$ ) is defined at a particular gate to source voltage ( $V_{GS1}$  and  $V_{GS2}$ ) in the corresponding MOSFET datasheet;  $I_Q$  is the driver's total quiescent current with no load at both drive outputs;  $N_{Q1}$  and  $N_{Q2}$  are number of upper and lower MOSFETs, respectively;  $UV_{CC}$  and  $LV_{CC}$  are the drive voltages for both upper and lower FETs, respectively. The  $I_Q \cdot V_{CC}$  product is the bias power of the driver without a load.

$$P_{DR} = P_{DR\_UP} + P_{DR\_LOW} + I_Q \cdot V_{CC}$$

$$P_{DR\_UP} = \left( \frac{R_{HI1}}{R_{HI1} + R_{EXT1}} + \frac{R_{LO1}}{R_{LO1} + R_{EXT1}} \right) \cdot \frac{P_{Qg\_Q1}}{2} \quad (EQ. 4)$$

$$P_{DR\_LOW} = \left( \frac{R_{HI2}}{R_{HI2} + R_{EXT2}} + \frac{R_{LO2}}{R_{LO2} + R_{EXT2}} \right) \cdot \frac{P_{Qg\_Q2}}{2}$$

$$R_{EXT1} = R_{G1} + \frac{R_{GI1}}{N_{Q1}} \quad R_{EXT2} = R_{G2} + \frac{R_{GI2}}{N_{Q2}}$$

The total gate drive power losses are dissipated among the resistive components along the transition path, as outlined in Equation 4. The drive resistance dissipates a portion of the total gate drive power losses, the rest will be dissipated by the external gate resistors ( $R_{G1}$  and  $R_{G2}$ ) and the internal gate resistors ( $R_{GI1}$  and  $R_{GI2}$ ) of MOSFETs. Figures 5 and 6 show the typical upper and lower gate drives turn-on current paths.

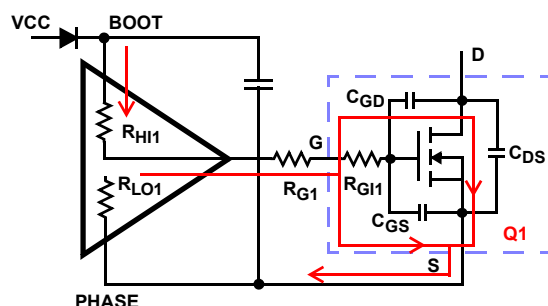


FIGURE 5. TYPICAL UPPER-GATE DRIVE TURN-ON PATH

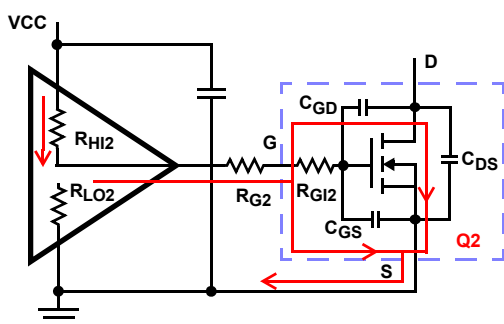


FIGURE 6. TYPICAL LOWER-GATE DRIVE TURN-ON PATH

## Application Information

### MOSFET and Driver Selection

The parasitic inductances of the PCB and of the power devices' packaging (both upper and lower MOSFETs) can cause serious ringing, exceeding absolute maximum rating of the devices. The negative ringing at the edges of the PHASE node could increase the bootstrap capacitor voltage through the internal bootstrap diode, and in some cases, it may overstress the upper MOSFET driver. Careful layout, proper selection of MOSFETs and packaging, as well as the driver can minimize such unwanted stress.

### Layout Considerations

A good layout helps reduce the ringing on the switching (PHASE) node and significantly lower the stress applied to the MOSFETs as well as the driver. The following advice is meant to lead to an optimized layout:

- Keep decoupling circuit loops (VCC-GND and BOOT-PHASE) as short as possible.
- Minimize trace inductance, especially on low-impedance lines. All power traces (UGATE, PHASE, LGATE, GND, VCC) should be short and wide, as much as possible.
- Minimize the inductance of the PHASE node. Ideally, the source of the upper and the drain of the lower MOSFET should be as close as thermally allowable.
- Minimize the current loop of the output and input power trains. Short the source connection of the lower MOSFET to ground as close to the transistor pin as feasible. Input capacitors (especially ceramic decoupling) should be placed as close to the drain of upper and source of lower MOSFETs as possible.

In addition, connecting the thermal pad of the DFN package to the power ground through one or several vias is recommended for high switching frequency, high current applications. This is to improve heat dissipation and allow the part to achieve its full thermal potential.

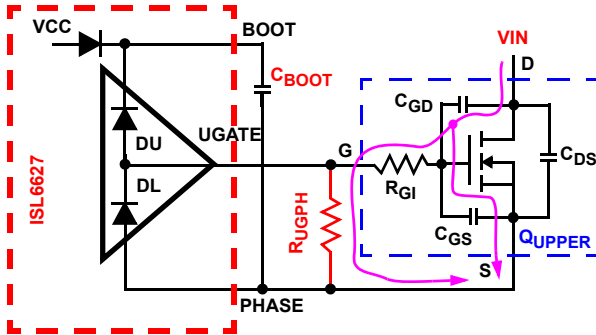
### Upper MOSFET Self Turn-On Effects at Startup

Should the driver have insufficient bias voltage applied, its outputs are floating. If the input bus is energized at a high  $dV/dt$  rate while the driver outputs are floating, due to self-coupling via the internal  $C_{GD}$  of the MOSFET, the gate of the upper MOSFET could momentarily rise up to a level greater than the threshold voltage of the device, potentially turning on the upper switch. Therefore, if such a situation could conceivably be encountered, it is a common practice to place a resistor ( $R_{UGPH}$ ) across the gate and source of the upper MOSFET to suppress the Miller coupling effect. The value of the resistor depends mainly on the input voltage's rate of rise, the  $C_{GD}/C_{GS}$  ratio, as well as the gate-source threshold of the upper MOSFET. A higher  $dV/dt$ , a lower  $C_{GD}/C_{GS}$  ratio, and a lower gate-source threshold upper FET will require a smaller resistor to diminish the effect of the internal capacitive coupling. For most applications, the integrated 20kΩ resistor is sufficient, not measurably affecting normal performance and efficiency.

The coupling effect can be roughly estimated with Equation 5, which assumes a fixed linear input ramp and neglects the clamping effect of the body diode of the upper drive and the bootstrap capacitor. Other parasitic components, such as lead inductances and PCB capacitances are also not taken into account. Figure 7 provides a visual reference for this phenomenon and its potential solution.

$$V_{GS\_MILLER} = \frac{dV}{dt} \cdot R \cdot C_{rss} \left( 1 - e^{\frac{-V_{DS}}{\frac{dV}{dt} \cdot R \cdot C_{iss}}} \right) \quad (EQ. 5)$$

$$R = R_{UGPH} + R_{GI} \quad C_{rss} = C_{GD} \quad C_{iss} = C_{GD} + C_{GS}$$

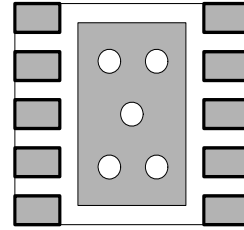


**FIGURE 7. GATE TO SOURCE RESISTOR TO REDUCE UPPER MOSFET MILLER COUPLING**

## General PowerPAD Design Considerations

Figure 8 shows the recommended use of vias on the thermal pad to remove heat from the IC. This typical array populates the thermal pad footprint with vias spaced three times the radius distance from the center of each via. Small via size is advisable, but not to the extent that solder reflow becomes difficult.

All vias should be connected to the pad potential, with low thermal resistance for efficient heat transfer. Complete connection of the plated-through hole to each plane is important. It is not recommended to use “thermal relief” patterns to connect the vias.



**FIGURE 8. PCB VIA PATTERN**

## Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to web to make sure you have the latest Rev.

| DATE               | REVISION | CHANGE                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
|--------------------|----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| January 24, 2014   | FN6992.1 | <p>On page 3 - added pin 10 to the description:<br/>PHASE - Connect this pin to the SOURCE of the upper MOSFET and the DRAIN of the lower MOSFET. This pin provides a return path for the upper gate drive.</p> <p>On page 10 - Updated "Products" verbiage to "About Intersil" verbiage</p> <p>On page 11 - Updated POD L10.3x3 from rev 6 to rev 9.</p> <p>Updates since rev 6:<br/>Removed package outline and included center to center distance between lands on recommended land pattern.<br/>Removed Note 4 "Dimension b applies to the metallized terminal and is measured between 0.18mm and 0.30mm from the terminal tip." since it is not applicable to this package. Renumbered notes accordingly.<br/>Corrected L-shaped leads in Bottom view and land pattern so that they align with the rest of the leads (L shaped leads were shorter).<br/>Added missing dimension 0.415 in Typical Recommended land pattern.</p> |
| September 22, 2011 | FN6992.0 | Initial release.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |

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# Package Outline Drawing

## L10.3x3

10 LEAD DUAL FLAT PACKAGE (DFN)

Rev 9, 10/13

